Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/774,293	SHIRAI ET AL.
Examiner	Art Unit
Tae H. Yoon	1714

SEARCHED							
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Class	Subclass	Date	Examiner				
523	216	11-2-06	2				
524	445						
264	331.11						

INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
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